PRELIMINARY PRODUCT INFORMATION



MOS INTEGRATED CIRCUIT $\mu PD63711$

COMPACT DISC DIGITAL SERVO/DATA PROCESSOR WITH ON-CHIP RF AMPLIFIER

The μ PD63711 is an LSI that has all of the functions required to control a CD player, with a digital servo, data processor, RF amplifier, audio DAC, and post-processing filter incorporated on a single chip. CD-TEXT is also supported.

Detailed function descriptions are provided in the following user's manuals. Be sure to read them before designing. μ PD63711 User's Manual: To be prepared

FEATURES

- Realization of set miniaturization by integrating a digital servo, data processor, 8-fs oversampling digital filter, D/A converter, and RF amplifier on a single chip.
- On-chip SCF (Switched Capacitor Filter) as audio DAC block post-processing filter
- Employment of digital loop filter for four servo systems. Since the filter coefficient is programmable, a variety of characteristics can be realized.
- On-chip automatic adjustment function. Automatic adjustments of focus offset, focus gain, focus balance, tracking offset, tracking gain, and tracking balance are possible.
- · On-chip 16-Kbit SRAM needed for de-interleaving.
- Since a digital PLL circuit is employed, the external components of the bit clock regeneration circuit are not needed.
- CIRC error correction capability C1: Double correction C2: Quadruple correction (CD-ROM mode)
- On-chip fourth order $\Delta\Sigma$ type one-bit D/A converter and post-processing filter
- On-chip mirror circuit, DEFECT circuit, RFOK circuit, and EFM comparator.
- A de-emphasis circuit can be controlled via a microcontroller for supporting connection with shock-proof ICs.
- Crystal oscillation stop function
- · Pickup of both current and voltage output can be supported.
- Single 5-V power supply

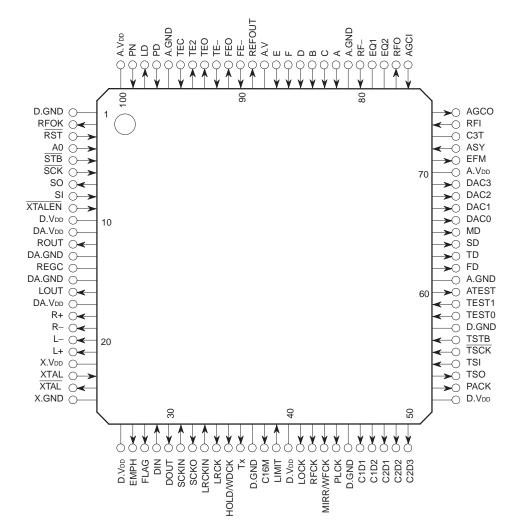
ORDERING INFORMATION

Part Number	Package
μPD63711GC-8EU	100-pin plastic LQFP (fine pitch) (14 × 14 mm)

The information contained in this document is being issued in advance of the production cycle for the device. The parameters for the device may change before final production or NEC Corporation, at its own discretion, may withdraw the device prior to its production. Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

PIN CONFIGURATION (Top View)

• 100-pin plastic LQFP (fine pitch) (14 \times 14 mm) μ PD63711GC-8EU



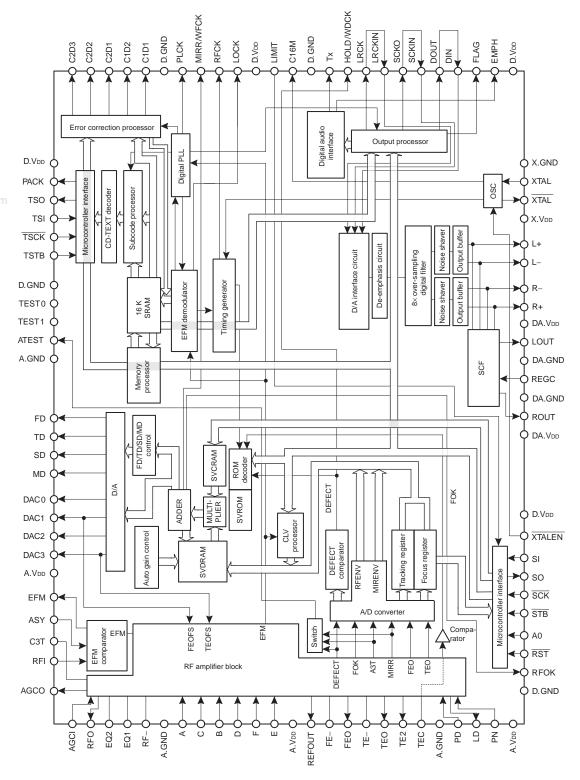
/ww.DataSheet4U.cor

NEC μ PD63711

A, C, B, D, F, E:	Error Signal Input	PLCK:	PLL Lock
A.GND:	Analog Ground	PN:	APC Circuit Polarity Control
A.V _{DD} :	Analog Power Supply	LIMIT:	Pick Inner Detect
A0:	Address 0	R+, R-:	R-channel Sound Data Output (PWM)
AGCI:	AGC Amp Input	REFOUT:	Reference Output
AGCO:	AGC Amp Output	REGC:	Capacitor Connection for Regulator
ASY:	Slice Level	RF-:	Impedance Connection to RF Amp for
ATEST:	Analog Test		Negative Feedback
C16M:	Clock 16 MHz	RFCK:	Read Frame Clock
C1D1, C1D2,:	Correction Data	RFI:	RF Signal Input
C2D1 to C2D3		RFO:	RF Amp Output
C3T:	Capacitance Connection for 3T Signal	RFOK:	RFOK Signal
	Detecting Circuit	ROUT:	R-channel Audio Signal Output
D.GND:	Digital Ground	RST:	Reset
D.V _{DD:}	Digital Power Supply	SCK:	Serial Clock
DA.GND:	D/A Converter Ground	SCKIN:	Serial Clock Input
DA.V _{DD} :	D/A Converter Power Supply	SCKO:	Serial Clock Output
DAC0 to DAC3:	D/A Converter Output	SD:	Sled Drive
DIN:	Data Input	SI:	Serial Data Input
DOUT:	Data Output	SO:	Serial Data Output
EFM:	EFM Signal	STB:	Strobe
EMPH:	Emphasis	TD:	Tracking Drive
EQ1, EQ2:	Equalizer Parts Connection for RF Amp	TE:	Tracking Error
FD:	Focus Drive	TE-:	Impedance Connection to Tracking
FE:	Focus Error		Error Amp for Negative Feedback
FE-:	Impedance Connection to Focus Error	TE2:	Tracking Error Amp Output Multiplied
	Amp for Negative Feedback		by Two
FEO:	Focus Error Amp Output	TEC:	Tracking Error Comparator
FLAG:	Flag	TEO:	Tracking Error Amp Output
HOLD/WDCK:	Hold Control/Word Clock	TESTO,	
L+, L-:	L-channel Sound Data Output (PWM)	TEST1:	Test
LD:	Laser Diode Control Current Output	TSCK:	Serial Clock for Text Data
LOCK:	Lock	TSI:	Parameter Input for Text Data
LOUT:	L-channel Audio Signal Output	TSO:	Serial Text Data Output
LRCK:	LR Clock	TSTB:	Text Parameter Strobe
LRCKIN:	LR Clock Input	Tx:	Transmit Data
MD:	Motor Drive	X.GND:	Crystal Oscillator Ground
MIRR/WFCK:	MIRR Signal/Write Frame Clock	X.VDD:	Crystal Oscillator Power Supply
PACK:	Pack Signal Sync	XTAL, XTAL:	Crystal Connection
PD:	Photo Diode Signal (for Detecting	XTALEN:	Crystal Oscillation Enable

Laser Power) Input

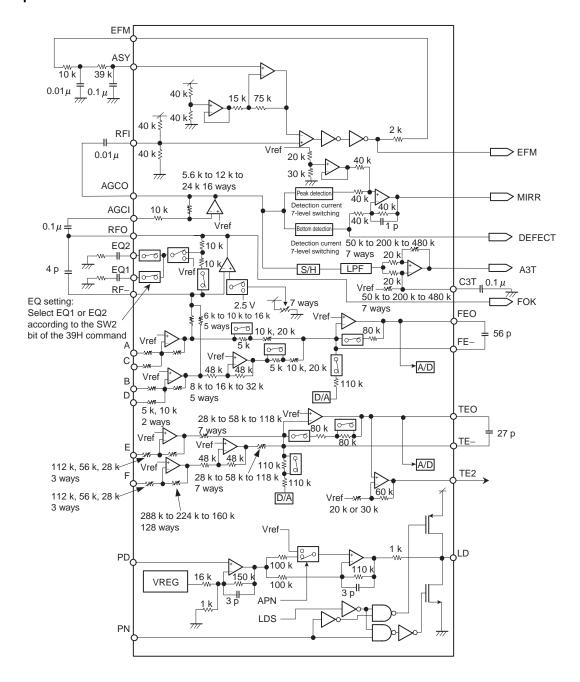
BLOCK DIAGRAM



www.DataSheet4U.co



RF amplifier block



Remark The unit of resistance is Ω and capacitance is F.

www.DataSheet4U.com

CONTENTS

1.	PIN FUNCTIONS	7
2.	DIGITAL FILTER FLOWCHARTS	12
3.	MICROCONTROLLER INTERFACE COMMANDS	
	3.1 Servo System Commands	16
	3.2 RF System Commands	30
	3.3 Signal Processing System Commands	41
	3.4 CD-TEXT Function	
et4U	3.5 Status	57
4.	PACKAGE DRAWING	58
5	RECOMMENDED SOLDERING CONDITIONS	59



1. PIN FUNCTIONS

F	in No.	Pin Name	Description	I/O	Initial Value
	1	D.GND	Logic circuit GND	-	_
	2	RFOK	RFOK signal output pin	0	Undefined
	3	RST	Reset signal input pin (Active low)	I	_
	4	A0	I	-	
m	5	STB	Data strobe signal input pin This is the signal for latching serial data inside the LSI.	ı	_
	6	SCK	Clock signal input pin for serial data input and output Input data from the SI pin is captured when this signal rises and serial data from the SO pin is output when it falls.	I	_
	7	SO	Outputs serial data and status signal	0	Undefined
	8	SI	Serial data input pin	I	_
	O	XTALEN	Crystal oscillation control pin. Be sure to input the reset signal before stopping crystal oscillation. When the status shifts from crystal oscillation stop mode to normal mode, input the reset signal after crystal oscillation has stabilized. XTALEN = L: Normal mode XTALEN = H: Crystal oscillation stop mode	I	_
	10	D.V _{DD}	Positive power supply pin to logic circuit	_	-
	11	DA.V _{DD}	Positive power supply pin to D/A converter block	-	_
	12	ROUT	R-ch audio signal output pin	AO	Undefined
	13	DA.GND	D/A converter block GND	-	_
	14	REGC	SCF regulator external capacitor connection pin	A-	_
	15	DA.GND	D/A converter block GND	_	_
	16	LOUT	L-ch audio signal output pin	AO	Undefined
	17	DA.V _{DD}	Positive power supply pin to D/A converter block	-	-
	18	R+	Right channel sound data output pin. PWM output	0	L
	19	R-			Н
	20	L–	Left channel sound data output pin. PWM output	0	Н
	21	L+			L
	22	X.V _{DD}	Positive power supply pin to crystal oscillator	_	_
	23	XTAL	Crystal oscillator connection pin (input)	I	_
	24	XTAL	Crystal oscillator connection pin (output)	0	_
	25	X.GND	Crystal oscillator GND	_	_
	26	D.V _{DD}	Positive power supply pin to logic circuit	_	_
	27	EMPH	Subcode Q pre-emphasis information output pin When applying emphasis, a high level is output. Commands can be used to switch polarity. F6H LSB EP = 0: Normal output EP = 1: Inverted output	0	Undefined

MANAY DataSheet411



Pin No.	Pin Name	Description	I/O	Initial Value
28	FLAG	Flag output pin indicating that the data currently being output was configured with uncorrectable data. (Active high)	0	Undefined
29	DIN	Serial data input pin to on-chip DAC If a DSP (etc.) is not connected, this must be shorted with the DOUT pin.	I	-
30	DOUT	Serial sound data output pin	0	L
31	SCKIN	Serial clock input pin to on-chip DAC	- 1	-
32	SCKO	Sound data output from DOUT changes with the falling of this clock. Ensure that the system connected in the next stage captures the data at the rising of this signal.	0	Undefined
33	LRCKIN	LRCK signal input pin to on-chip DAC	I	_
t4U. 34 m	LRCK	Signal that distinguishes left channel and right channel of sound data output from DOUT	0	Undefined
35	HOLD/ WDCK	Defect detection output pin (HOLD) Pin that outputs a signal twice the frequency of LRCK (88.2 kHz) (WDCK) HOLD and WDCK can be switched by microcontroller.	0	Undefined
36	Tx	Data output pin of digital audio interface	0	L
37	D.GND	Logic circuit GND	_	-
38	C16M	Buffering output pin of oscillation clock	0	-
39	LIMIT	The state of this pin is output in Bit5 of the status output.	I	-
40	D.V _{DD}	Positive power supply pin to logic circuit	_	-
41	LOCK	EFM synchronization detection signal This is high level if the frame counter output matches the synchronization pattern detection signal in the EFM demodulation block, and low level if they do not match.	0	Undefined
42	RFCK	Frame synchronization signal of XTAL system This is the divided crystal resonator clock and indicates a period of one frame (7.35 kHz).	0	Undefined
43	MIRR/ WFCK	Mirror output pin (MIRR) Frame synchronization signal of PLL system. This signal is a signal with a frequency that is a division of the basic frequency (44.1 kHz) of the read signal acquired from the PLL system and is approximately equal to 1 frame cycle (7.35 kHz) (WFCK). MIRR and WFCK can be switched by microcontroller.	0	Undefined
44	PLCK	Pin for bit clock monitor When a PLL lock occurs, the falling edge of this signal locks to the EFM signal.	0	Undefined
45	D.GND	Logic circuit GND	_	_
46	C1D1	Output pins that indicate the results of C1 error correction	0	Undefined
47	C1D2	These pins are defined until the falling edge of RFCK.		
48	C2D1	Output pins that indicate the results of C2 error correction	0	Undefined
49	C2D2	These pins are defined until the falling edge of RFCK.		
50	C2D3			
51	D.V _{DD}	Positive power supply pin to logic circuit	-	-
52	PACK	PACK synchronization signal of CD-TEXT The fall of this signal indicates the beginning of the pack.	0	Undefined

www.DataShe



I/O Initial Value Pin No. Pin Name Description TSO 0 53 CD-TEXT data serial output pin Undefined TSI CD-TEXT control parameter serial input pin 54 1 TSCK 55 CD-TEXT serial clock input pin 1 56 **TSTB** CD-TEXT parameter strobe signal input pin Τ D.GND 57 Logic circuit GND 58 TEST0 Test pins. Normally, connect to GND. 59 TEST1 **ATEST** Undefined 60 Test pin. Normally, leave open. AO 61 A.GND Analog circuit GND FD 62 Focus drive output pin ΑO 1/2 A.VDD TD 1/2 A.VDD 63 Tracking drive output pin AO SD 64 Sled drive output pin AO 1/2 A.VDD 65 MD Spindle drive output pin AO 1/2 A.VDD 66 DAC₀ DAC output pin for adjustment. Outputs CRAM 7FH setting value. AO 1/2 A.VDD 67 DAC1 DAC output pin for adjustment. Outputs CRAM 7CH setting value. AO 1/2 A.VDD (On-chip RF FE amplifier offset) DAC2 68 DAC output pin for adjustment. Outputs CRAM 7DH setting value. AO 1/2 A.VDD 69 DAC3 DAC output pin for adjustment. Outputs CRAM 7EH setting value. AO 1/2 A.VDD (On-chip RF TE amplifier offset) 70 A.V_{DD} Positive power supply pin to analog circuit **EFM** 71 EFM signal output pin 0 Undefined 72 ASY EFM comparator reference voltage input pin ΑI 73 C3T Capacitor connection pin for 3T detection Α-74 RFI RF signal input pin for EFM data generation ΑI 75 **AGCO** RF signal output pin after gain adjustment AO 1/2 A.VDD 76 **AGCI** RF-AGC amplifier input pin ΑI 1/2 A.VDD 77 RFO RF summing amplifier output pin ΑO Undefined 78 EQ2 RF amplifier equalizer parts connection pin 79 EQ1 RF-RF summing amplifier inverse input pin 80 ΑI 81 A.GND Analog circuit GND 82 Α Photo-detector A input pin ΑI 1/2 A.VDD С 1/2 A.VDD 83 Photo-detector C input pin ΑI 84 В Photo-detector B input pin ΑI 1/2 A.VDD 85 D Photo-detector D input pin ΑI 1/2 A.VDD F 1/2 A.VDD 86 Photo-detector F input pin ΑI Ε 87 Photo-detector E input pin ΑI 1/2 A.VDD 88 A.V_{DD} Positive power supply pin to analog circuit 89 REFOUT AO 1/2 A.VDD Reference potential output pin FE-90 Focus error amplifier inverse input pin ΑI 1/2 A.VDD

MANA DataSheet411

Pin No.	Pin Name	Description	I/O	Initial Value
91	FEO	Focus error amplifier output pin	AO	½ A.V _{DD}
92	TE-	Tracking error amplifier inverse input pin	Al	½ A.V _{DD}
93	TEO	Tracking error amplifier output pin	AO	½ A.V _{DD}
94	TE2	Pin from which tracking error is output after amplification	AO	½ A.VDD
95	TEC	Tracking comparator input pin Inputs a tracking error signal whose DC component is cut. A tracking zero-cross is detected inside the LSI using this signal.	AI	-
96	A.GND	Analog circuit GND	-	-
97	PD	PD detection signal input pin for LD output monitor	Al	GND
98 4U com	LD	LD control current output pin	AO	Undefined
99	PN	APC circuit control polarity setting pin	I	-
100	A.V _{DD}	Positive power supply pin to analog circuit	_	-

Cautions 1. Do not allow any input pin to exceed the power supply voltage.

2. Make each power supply voltage (D.VDD, A.VDD, X.VDD, DA.VDD) the same potential.

Remark The meanings of symbols in the I/O column are as follows.

I: Logic level input pin

O: Logic level output pin

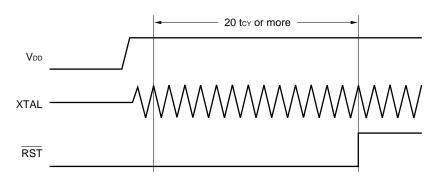
AI: Analog input pin

AO: Analog output pin

A-: Analog parts connection pin

Reset input

In the μ PD63711, when the reset signal (active low) is input from the \overline{RST} pin (pin 3) while the clock is being input from the XTAL pin (pin 23), it takes up to 20 clocks (about 1.2 μ s) before the statuses of all the pins are defined. To allow for this, therefore, be sure to input the reset signal for a sufficient amount of time.

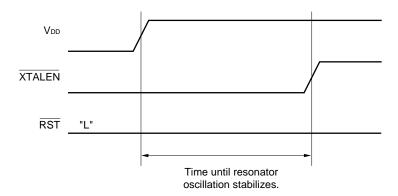




Cautions on using the XTALEN pin

When stopping oscillation using the XTALEN pin, note the following.

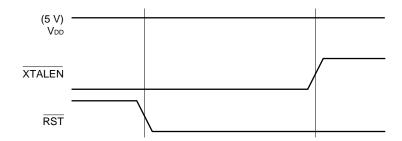
1. When stopping oscillation immediately after the power supply is turned on.



ww.DataSheet4U.com

The clock must be supplied while the reset signal is active, as in the above chart, even when stopping oscillation immediately after turning on the power supply.

2. When stopping oscillation in the normal use state



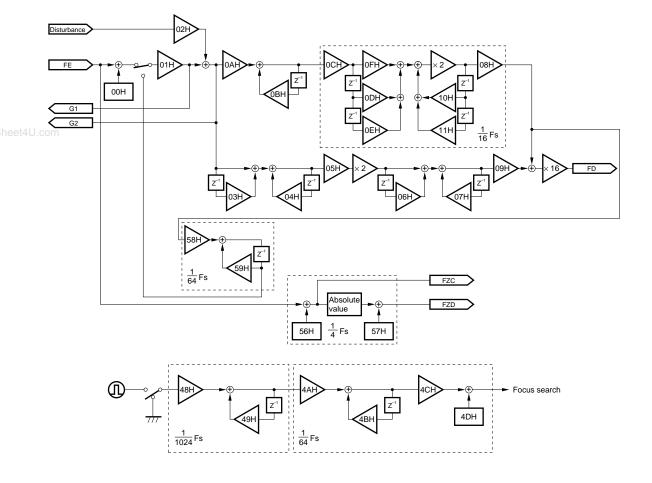
Be sure to set the reset signal to active before stopping oscillation.

If oscillation is stopped without setting the reset signal to active, output of the servo drive or sound will stop or become unstable, which may cause bugs in external devices.

2. DIGITAL FILTER FLOWCHARTS

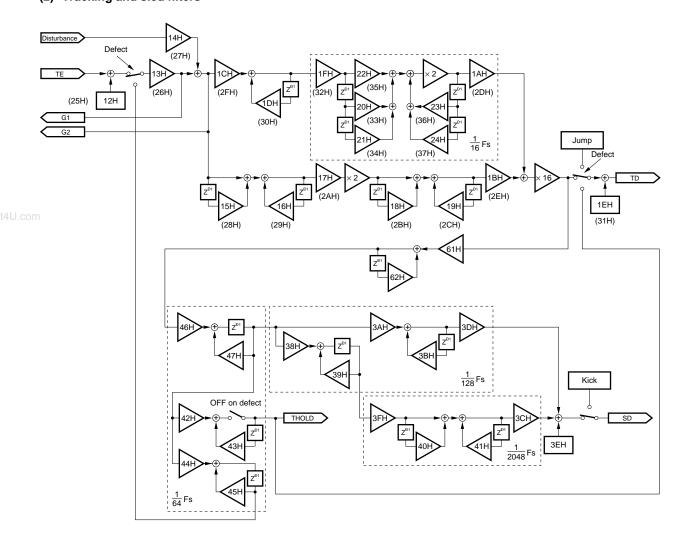
Flowcharts of the digital filters are shown below. Fs = 176.4 kHz.

(1) Focus filter



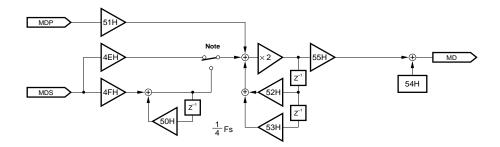


(2) Tracking and sled filters



Remark Bank 1 addresses are shown in parentheses.

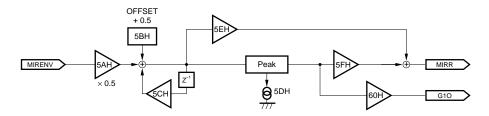
(3) Spindle system



Note This switch is controlled according to the CLV lock decision signal (same signal as FR bit in status signal).

Asynchronous state: $FR = 0 \rightarrow Switch$ is down Synchronous state: $FR = 1 \rightarrow Switch$ is up

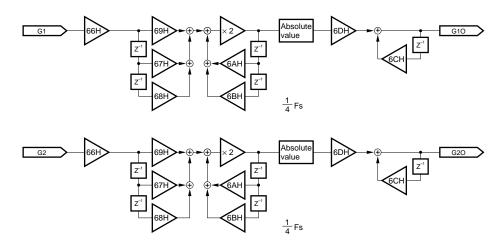
(4) MIRR signal



(5) RFOK signal

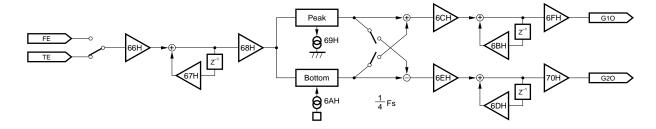


(6) Gain detection filter



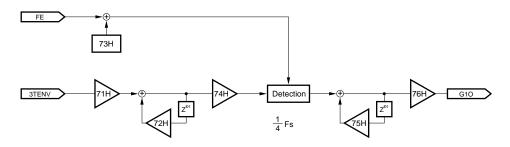


(7) Balance adjustment filter



(8) 3T detection filter





3. MICROCONTROLLER INTERFACE COMMANDS

3.1 Servo System Commands

Table 3-1. Servo System Command Functions

Command	Function	Reference
00H	Writing data to CRAM	-
01H	CRAM address setting	_
10H	Servo control 0	p.18
11H	Servo control 1	p.20
12H	Servo control 2	p.22
13H	Focus search setting	p.23
14H	Disturbance generation and SO data output settings	p.24
15H	Half-wave brake control	p.26
17H	Disturbance frequency and level settings	p.27
18H	Defect comparator level setting	p.28
22H	Track jump kick time setting,	p.29
23H	traverse counter setting	
24H		

Table 3-2. List of Servo System Commands (1/2)

Command				Paramet	er (Data)								
(Command Code)	MSB	6	5	4	3	2	1	LSB					
00H	Writing data to CRAM												
01H		CRAM address											
10H	SK	TM	TEH	FR	TK	ТВ	T-CNT	BRK					
11H	FON	TON	SON	MON	FST	DFCT	JSK	TAB					
12H	BALON	SDMSK	SDL1	SDL0	DFCTT	SCV	0	TFP					
13H	0	0	0	0	0	0	T1	T0					
14H	GST	GON	GFT	T/3	G/B	SEL2	SEL1	SEL0					
15H	BALSW	0	0	0	BKLMT	0	0	0					
17H	FD2	FD1	FD0	FRQ4	FRQ3	FRQ2	FRQ1	FRQ0					
18H	DF7	DF6	DF5	DF4	DF3	DF2	DF1	DF0					
22H	0			TRA	CK KICK TIM	1E A							
23H	0	TRACK KICK TIME B/TRAVERSE COUNTER N (H)											
24H		Т	RAVERSE C	OUNTER N (L	_)/TRACK JU	MP COUNTE	R						

www.DataSheet4II.com



Table 3-2. List of Servo System Commands (2/2)

CRAM Address	CRAM Data
77H	TRACK KICK LEVEL A (kick level)
78H	TRACK KICK LEVEL B (brake level)
79H	SLED KICK LEVEL
7AH	Sled dead zone level setting (–)
7BH	Sled dead zone level setting (+)
7CH	DAC level setting for adjustment (DAC1 pin output) (On-chip RF FE amplifier offset)
7DH	DAC level setting for adjustment (DAC2 pin output)
7EH	DAC level setting for adjustment (DAC3 pin output) (On-chip RF TE amplifier offset)
7FH	DAC level setting for adjustment (DAC0 output)

Caution Do not send an undefined command.

..... DetaCha



(1) 10H command (Servo control 0)

MSB			Com	mand				LSB		
0	0	0	1	0	0	C)	0		
MSB	T. 4	TELL		meter	TD	T-0	NIT	LSB		
SK	TM	TEH	FR	TK	ТВ	T.C	ΝI	BRK		
									BRK	Half-Wave Brake Circuit
									0	_
									1	ON
									T-CNT	Function of TK Bit
									0	Start of track jump sequencer
heet4U.com									1	Load value in traverse counter
									ТВ	Tracking Filter Coefficient Bank
									0	Bank 0
									1	Bank 1
									TK	Track Jump/Load Trigger
									0	-
									1	Execute operation specified by T-CNT b
									FR	Output Polarity Switching
									0	Output level × -1
									1	Leave output level unchanged
										3
									TEH	Error Hold Function on Track Jum
		•							0	Hold reference (data 00)
									1	Hold previous value
									TM	Tracking Mute
									0	Output results of tracking filter (normal operation)
									1	Output value specified by TEH bit
									SK	Sled Kick
									0	
									1	Execute sled kick



[Functional description]

BRK: Controls the half-wave brake circuit.

"1" Half-wave brake circuit is ON

T-CNT: Used in combination with the TK bit.

"0" If TK = 1 is set, start a track jump sequencer

"1" If TK = 1 is set, load the values of registers 23H and 24H in the traverse counter

TB: Switches the tracking filter coefficient bank.

"0" Tracking filter bank 0

"1" Tracking filter bank 1

TK: This is the track jump trigger and traverse counter load control.

It has two meanings depending on the T.CNT bit. An operation using the TK bit is a one-shot operation

that operates only in the instant this is set to "1".

FR: Controls the output level polarity when tracking and sled kicking.

"0" Output the value in the output level register (CRAM 77H to 79H) multiplied by -1

"1" Output the value in the output level register unchanged

TEH: Controls the error hold function when track jumping.

Selects tracking output when SK = TM = 1.

"0" Hold reference

"1" Hold previous value

TM: Controls tracking mute.

"0" Output the arithmetic result of the tracking filter (normal operation)

"1" Either hold the previous value or hold a reference (data value 00) depending on the TEH bit specification

SK: Controls sled kick.

'1" Perform sled kick using the value set in CRAM 79H

www.DataShee**‡5**U.com



(2) 11H command (Servo control 1)

_	MSB			Comr				LSB		
L	0	0	0	1	0	0	0	1		
г	MSB	TON	LOON	Parar		DECT	ICIC	LSB		
L	FON	TON	SON	MON	FST	DFCT	JSK	TAB		
									TAB Track Jump Sequencer	
									0 -	
									1 Halt operation	
									JSK Sled Kick	
									0 _	
Sh	n e e t 4	ł U							1 Execute sled kick	
									DFCT Error Hold Output Upon Defect De	tectio
									0 No	
									1 Yes	
									FST Focus Search	
									0 –	
									1 Start focus search	
									MON Spindle Servo Output	
									0 OFF (D/A output stopped, 1/2 A.Vdd)	
									1 ON	
									SON Sled Servo Output	
									0 OFF (D/A output stopped, 1/2 A.VDD)	
									1 ON	
									TON! Trealing Come Output	
									TON Tracking Servo Output	
									0 OFF (D/A output stopped, 1/2 A.Vbb) 1 ON	
									1 ON	
									FON Focus Servo Output	_
									0 OFF (D/A output stopped, 1/2 A.Vdd)	
									1 ON	



[Functional description]

TAB: Controls close of track jump sequencer operation.

"1" Halt track jump sequencer operation

An operation using the TAB bit is a one-shot operation that operates only on the instant this is set to "1".

JSK: Controls sled kick when track jumping.

"1" Perform sled kick in the track jump period using the level set in CRAM 79H

DFCT: Controls error hold output on defect detection.

"0" No hold output

All switches controlled by a DEFECT signal in the focus filter and tracking filter are fixed in the up position (normal position).

"1" Hold output

Switch the above switches according to the DEFECT signal state.

FST: Focus search control.

"1" Start focus search

FON must be "1" at this time.

MON: Controls whether spindle servo output (D/A output) is ON or OFF.

"0" D/A output is OFF, output $\frac{1}{2}$ A.VDD

"1" D/A output is ON

SON: Controls whether sled servo output (D/A output) is ON or OFF.

"0" D/A output is OFF, output $\frac{1}{2}$ A.V_{DD}

"1" D/A output is ON

TON: Controls whether tracking servo output (D/A output) is ON or OFF.

"0" D/A output is OFF, output $\frac{1}{2}$ A.VDD

"1" D/A output is ON

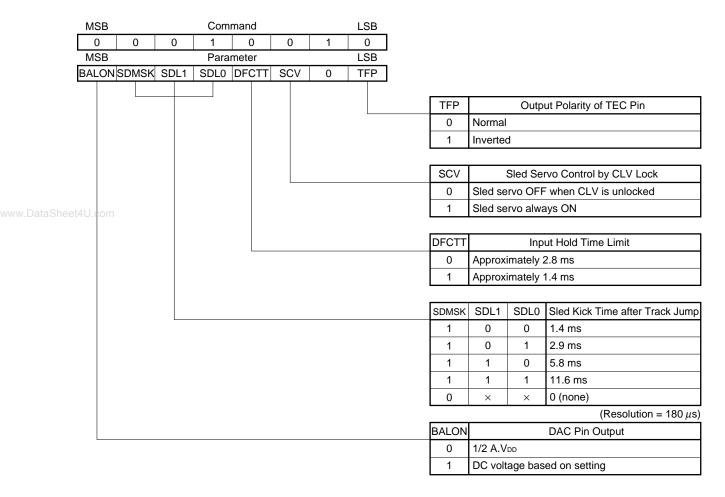
FON: Controls whether focus servo output (D/A output) is ON or OFF.

"0" D/A output is OFF, output $\frac{1}{2}$ A.VDD

"1" D/A output is ON



(3) 12H command (Servo control 2)



[Functional description]

TFP: TEC signal (tracking error zero-cross signal) polarity control.

"0" Normal output

"1" Inverted output

SCV: Sled servo control by CLV lock.

"0" Sled servo is OFF (D/A output halted) when CLV is unlocked (when FR bit in status signal

is 0)

"1" Sled servo is always ON regardless of CLV lock

At the time of a sled kick, D/A output is performed regardless of a CLV lock.

DFCTT: Sets the tracking or focus input hold time limit when the absence of an RF signal is detected.

"0" Approximately 2.8 ms
"1" Approximately 1.4 ms

SDMSK, SDL[1:0]: Sets the sled kick time after a track jump.

BALON: Sets DAC0 to DAC3 pin outputs.

This bit is set to "0" on a reset.

"0" Output $\frac{1}{2}$ A.VDD

"1" Output DC voltage set using CRAM 7FH, 7CH, 7DH, and 7EH from DAC0 to DAC3 pins

respectively



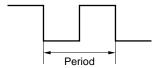
(4) 13H command (Focus search setting)

MSB	MSB Command										
0	0	0	1	0	0	1	1				
MSB Parameter											
0	0	0	0	0	0	T1	T0				

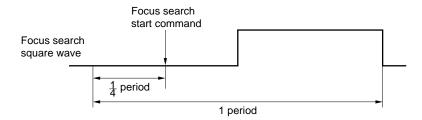
T1	T0	Square Wave Period on Focus Search
0	0	Approximately 0.37 s
0	1	Approximately 0.74 s
1	0	Approximately 1.49 s
1	1	Approximately 2.97 s

www.DataSheet4U.com[Functional description]

T[1:0]: Sets the period of the square wave for focus search.



As shown below, square wave output on focus search is begun from the time one quarter of the period has gone by.





MSB

(5) 14H command (Disturbance generation and SO data output setting)

Command

_	IVISD				Con				LOD				
L	0		0	0	1	0	1	0	0				
	MSB				Para	meter			LSB				
	GST	G	ON	GFT	T/3	G/B	SEL2	SEL1	SEL0				
											T		T
										SEL2	SEL1	SEL0	+
										0	1	0	FE
										0	1	1	TE
										1	0	0	G1
										1	0	1	G2
	U.co									T/3	G/B	(Output Data
										0	0	Gain d	letection resu
										0	1	adjustr	f filter for tra ment EAK, TE·BO
										1	0	!	plitude dete
										1	1	3T det	ection result
											'		
										GFT			ce Feed Desi
										0	Focus	equalize	er (FE signal)
										1	Trackin	ıg equal	izer (TE sigr
			L							GON	Feed o	of Distur	bance to TE
										0	Disturb	ance O	FF
										1	Disturb	ance Ol	N
										GST	Fetch A	rithmetic	Result of Fil
										0			_
										1	Fetch		

LSB

[Functional description]

SEL[2:0]: Sets SO data output.

G/B, T/3: Sets data to latch to G1 and G2 registers inside the LSI.

GFT: Selects the disturbance feed destination.

GON: Controls whether disturbance feed to the TE or FE filters is ON or OFF.

GST: Controls fetching of arithmetic result of filter for gain detection.

"1" Arithmetic result of filter for gain detection (G10, G20) is latched to G1 and G2 registers inside LSI (during which time S0 pin outputs high level and is in BUSY state)

On data readout from the serial interface using the 14H command, the following one-bit shift processing toward the MSB is executed for G1 and G2 data read from the serial interface by means of the settings of T/3 and G/B bits.

From signal flow MSB LSB 15 14 13 12 11 10 8 6 5 0 Double 6 5 4 2 0 3

Figure 3-1. Data Readout Block

The aim of one-bit shift processing toward the MSB is to improve the bit precision of values that are read. For filters such as the gain detection filter, which always output positive values, the sign bit has no meaning. By performing one-bit shift processing toward the MSB on values read from the serial interface in the μ PD63711, the precision of a value that is read is improved by one bit from reading the LSB bit instead of the sign bit.

When reading sign output (positive and negative values) as in the case of balance detection, as a procedure for avoiding losing a sign due to one-bit shift processing toward the MSB, multiply (shift one bit to the right) a value less than 0.5 in the final output stage multiplier in advance. By doing so, the correct sign value is read.



(6) 15H command (Half-wave brake control)

MSB			Com	nmand			LSB	_		
0	0	0	1	0	1	0	1			
MSB			Para	meter			LSB			
BALSW	0	0	0	BKLMT	0	0	0			
									BKLMT	Half-Wave Brake Control
									0	-
									1	Half-wave brake OFF at or above approximately 1.4 ms
								'		
									BALSW	TBAL or FBAL Detection Filter Internal SW
et4U.com									0	OFF
									1	ON

[Functional description]

BKLMT: Controls half-wave brake circuit

"1" Half-wave brake is OFF at or above approximately 1.4 ms

BALSW: Controls addition/subtraction switch inside tracking or focus balance detection filter.

"0" OFF

"1" ON

(7) 17H command (Disturbance frequency and level setting)

MSB			Com	mand			LSB	_		
0	0	0	1	0	1	1	1			
MSB			Parar	meter			LSB			
FD2	FD1	FD0	FRQ4	FRQ3	FRQ2	FRQ1	FRQ0			
									FRQ[4:0]	Disturbance Frequency Setting
									FD[2:0]	Disturbance Level Setting

[Functional description]

FRQ[4:0]: Sets the disturbance frequency (5-bit absolute value).

FD[2:0]: Sets the disturbance level (3-bit absolute value).

The disturbance frequency and disturbance level are calculated using the following expressions.

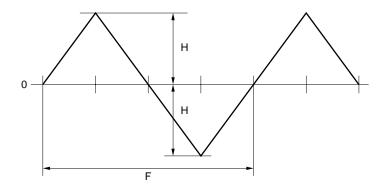
Frequency (F) =
$$\frac{fs}{(FQ + 1) \times 4}$$

Level $(H) = FD \times (FQ + 1)$

fs: $\frac{176.4 \text{ kHz}}{2} = 88.2 \text{ kHz}$

FQ: Value set in FRQ[4:0]
FD: Value set in FD[2:0]

Caution Set FD to the greatest value that satisfies $H \le 127$.



Example When 17H register = B5H

 $B5H = 10110101B \rightarrow FD = 101B, FQ = 10101B$

Since FQ = 21, $F = \frac{88.2 \text{ kHz}}{(21 + 1) \times 4} = 1.0 \text{ kHz}$

Since FD = 5, H = $5 \times (21 + 1) = 110 = 6EH$

17H register = D5H is not possible because FD = 6, H = $6 \times (21+1) = 132$, and H then exceeds 127.

(8) 18H command (Defect comparator level setting)

MSB			Com	mand			LSE
0	0	0	1	1	0	0	0
MSB			Para	meter			LSB
DF7	DF6	DF5	DF4	DF3	DF2	DF1	DF0

[Functional description]

DF[7:0]: Set the defect signal comparator level.

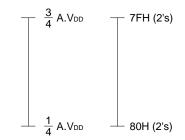
The range of $\frac{1}{2}$ A.V_{DD} $\pm \frac{1}{4}$ A.V_{DD} can be set in 256 8-bit levels.

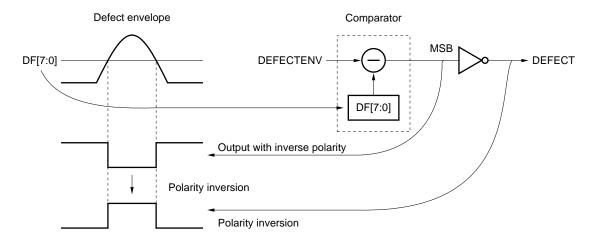
The setting value becomes the comparison threshold value.

The comparison result has the inverse polarity of the input (because the MSB after subtracting is used).

Output is inverted (because the signal after comparator output handled as a signal absence detection by DEFECT = H).

The relationship between comparator level setting values and defect envelope signal voltages is shown below.







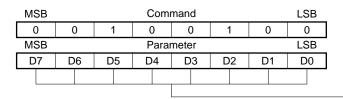
(9) 22H, 23H, and 24H commands (Track jump control)

_	MSB			Comi	mand			LSB
	0	0	1	0	0	0	1	0
	MSB			Parar	meter			LSB
	0	D6	D5	D4	D3	D2	D1	D0

D[6:0] Track Kick Time A

MSB			Com	mand			LSB
0	0	1	0	0	0	1	1
MSB			Parai	meter			LSB
0	D6	D5	D4	D3	D2	D1	D0

D[6:0] Track Kick Time B/Traverse Counter N (H)



D[7:0] Traverse Counter N (L)/ Track Jump Counter

[Functional description]

Track jump

22H: The kick time setting

7 bits wide. Always set the MSB to 0.

The kick time is calculated using the following expression.

Kick time =
$$\frac{\text{(Setting value + 1)} \times 1}{\text{fs}} \text{ (fs = } \frac{176.4 \text{ kHz}}{2} = 88.2 \text{ kHz)}$$

23H: Brake time setting

7 bits wide. Always set the MSB to 0.

The brake time is calculated using the following expression.

Brake time =
$$\frac{\text{(Setting value + 1)} \times 1}{\text{fs}} \text{ (fs = } \frac{176.4 \text{ kHz}}{2} = 88.2 \text{ kHz)}$$

24H: Track counter setting

7 bits wide. Always set the MSB to 0.

The value set in 24H is used as a counter value.

Traverse count

23H: Traverse counter setting (higher 7 bits, always set MSB to 0)

24H: Traverse counter setting (lower 8 bits)

The values set in 23H and 24H (15 bits wide) are used as counter values.

23H and 24H are used both when track jumping and when counting traverses, and are switched according to the setting of the T-CNT bit of the 10H command.

3.2 RF System Commands

Table 3-3. Functions of RF System Commands

Command	Function	Reference
30H	AGC amplifier gain setting, RF amplifier offset setting	p.31
31H	3T component detection gain setting, 3T detection circuit LPF setting, TE amplifier gain setting	p.32
32H	FE, RF, and TE amplifier gain settings	p.33
33H	TE amplifier balance setting	p.34
34H	MIRR detection block peak and bottom time constant settings, TE2 signal gain setting	p.35
35H	3T component extraction from RF signal timing setting	p.37
36H	EFM output block buffer setting, RF amplifier external load resistor setting	p.38
37H	Setting of output to ATEST pin, FE and TE amplifier load resistors setting	p.39
39H	Playback speed setting, EQ speed selection (x1 or x2), APC amplifier polarity selection, Current input type setting	p.40

Table 3-4. List of RF System Commands

Command				Paramet	er (Data)			
(Command Code)	MSB	6	5	4	3	2	1	LSB
30H	DRF3	DRF2	DRF1	DRF0	GA3	GA2	GA1	GA0
31H	GTU1	GTU0	F31	F30	GF5	G32	G31	G30
32H	GT2	GT1	GT0	GF4	GF3	GF2	GF1	GF0
33H	TB6	TB5	TB4	TB3	TB2	TB1	TB0	IVS2
34H	TM3	TM2	TM1	GTEC	SOST	TM5	TM4	TMC
35H	0	3TS6	3TS5	3TS4	3TS3	3TS2	3TS1	3TS0
36H	DEQO	GR2	GR1	GR0	SEQ	0	0	EFMO
37H	TFO	TTO	0	0	0	TS3	TSD	TSM
39H	LDS	0	IVS	SW2	APN	0	0	CV2

Caution Do not send an undefined command.

www.DataSheet4U.com



(1) 30H command (Settings of AGC amplifier gain and RF amplifier offset)

_	MSB			Com	mand			LSB
	0	0	1	1	0	0	0	0
-	MSB				meter			LSB
L	DRF3	DRF2	DRF1	DRF0	GA3	GA2	GA1	GA0
			\vdash				\perp	

Note Values shown here are standard values, not rated values.

0.75 V

Remark The mark * indicates the contents set after a reset.

[Functional description]

GA[3:0]: Used in setting the AGC amplifier gain.

Perform gain setting while monitoring the MIRR signal's (peak) - (bottom) signal. The 37H command can be used to output the value of a MIRR signal from the ATEST pin before A/D conversion. In addition, in order to monitor amplitude stably, make adjustments by using the 34H command to maximize the time constant.

DRF[3:0]: Used in setting the RF amplifier output DC voltage.

Can be cancelled using DEQO in the 36H command.



(2) 31H command (Settings of 3T component detection gain, 3T detection circuit LPF, and TE amplifier gain)

	MSB			Com	mand				LSB					
	0	0	1	1	0	0	0		1	1				
	MSB			Para	meter				LSB	•				
	GTU1	GTU0	F31	F30	GF5	G32	G3°	1	G30]				
											G32	G31	G30	3T Detection Circuit Gai
											1	0	1	+8.0 dB
											1	1	0	+14.0 dB
											1	1	1	+16.5 dB
											0	0	0	* +20.0 dB
											0	0	1	+23.5 dB
Sheet	4U.com										0	1	0	+26.0 dB
											0	1	1	+28.0 dB
											GF5	GF4	FI	E Amplifier Gain Adjustment
											1	1	+2.5 d	В
											1	0	-2.0 d	В
											0	1	+6.0 d	IB
											0	0	* 0 dB	
											F31	F30		3T Circuit LPF after S/H
											1	0	fc = 50) kHz
											0	0	* fc = 1	00 kHz
											0	1	fc = 20	00 kHz
												I		
											GTU1	GTU0	TE	Amplifier Gain Adjustment
	1										0	0	* +14 d	B ain TYP setting of 32H
											0	1	+6 dB	· · · · · · · · · · · · · · · · · · ·
											1	0	+12 dl	

Remark The mark * indicates the contents set after a reset.

[Functional description]

G3[2:0]: Used in setting the 3T detection circuit sensitivity.

When disturbance is injected into the FE system, an amplitude of approximately 2.0 V_{p-p} is obtained in

the default state when the RF signal fluctuates 20%.

The LPF for eliminating noise after S/H in the 3T detection circuit.

Since S/H samples using an EFM high frequency signal, LPF is set for stability.

GF5: Adjusts the FE amplifier gain.

Changes the input resistor value of the FE amplifier second stage.

Used with the GF4 bit of the 32H command.

GTU[1:0]: Used to raise the TE amplifier gain.

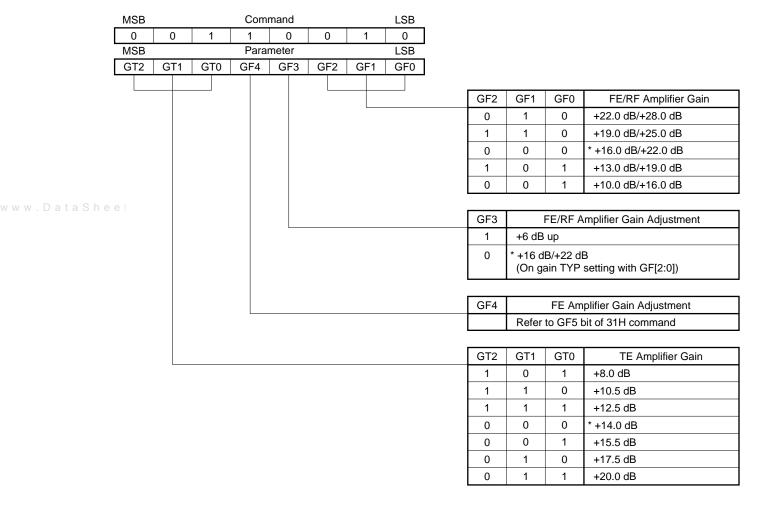
Switches the gain by changing the input resistor value. Note that GTU0 and GTU1 cannot be used

together.

F3[1:0]:



(3) 32H command (FE, RF, and TE amplifier gain settings)



Remark The mark * indicates the contents set after a reset.

[Functional description]

GF[2:0]: Sets the FE amplifier and RF amplifier gain.

Raising/decreasing the gain can be performed in 6-dB units and can be set in variations of five stages.

GF3: Raises the FE amplifier and RF amplifier gain +6 dB.

Changes the resistor value of first-stage amplifier input.

GF4: Adjusts the FE amplifier gain.

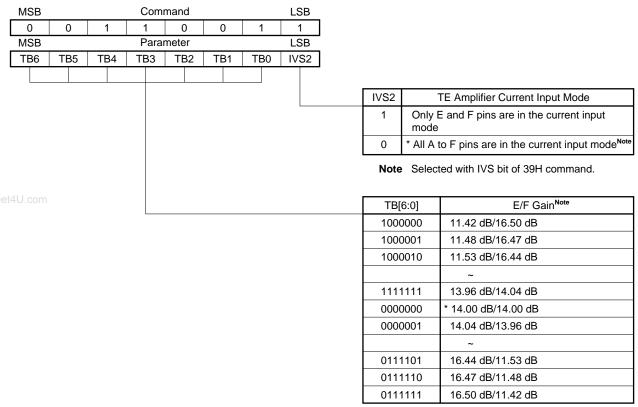
Used with the GF5 bit of the 31H command.

GT[2:0]: Sets the TE amplifier gain.

Raising/decreasing the gain can be performed in 6-dB units and can be set in variations of seven stages.



(4) 33H command (TE amplifier balance setting)



(128 divisions)

Note Values shown above are standard values, not rated values.

Remark The mark * indicates the contents set after a reset.

[Functional description]

IVS2: Sets E and F pins to the current input mode.

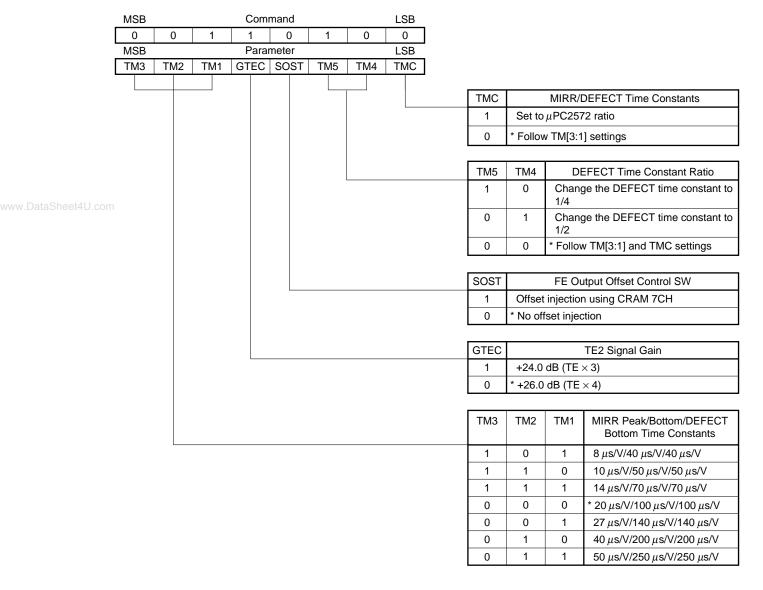
When using this mode, be sure to set the IVS bit of the 39H command to 1.

TB[6:0]: Prior stage to the TE amplifier. Sets the photo-detector E and F signal gains.

Switching is possible in 128 ways over an adjustment range of ±5 dB.



(5) 34H command (Settings of MIRR detection block peak and bottom time constants and TE2 signal gain)



Remark The mark * indicates the contents set after a reset.

[Functional description]

TMC: Changes MIRR/DEFECT time constants to the μ PC2572 ratio.

Example MIRR peak/bottom/DEFECT bottom = $20 \mu s/V/400 \mu s/V/100 \mu s/V$

(When TM[5:4] = [0:0], TMC = 1, TM[3:1] time constants is TYP)

TM[5:4]: Of the MIRR/DEFECT time constants set using TM[3:1], changes only the DEFECT detection time

constant. Valid only when TMC is set to "1".

Example MIRR peak/bottom/DEFECT bottom = $20 \mu s/V/400 \mu s/V/50 \mu s/V$

(When TM[5:4] = [0,1], TMC = 1, and TM[3:1] time constant is TYP)

SOST: Controls the offset level of the on-chip FE amplifier using CRAM 7CH.

GTEC: Used in setting the TE2 signal gain. This setting can be used to set the TE2 signal gain to 3 times or 4

times that of the TE signal.

TM[3:1]: Used in setting the MIRR/DEFECT circuit peak and bottom time constants.

MIRR signal generation............A MIRR signal is generated by superimposing RF (peak) - (bottom)

detection waveform on DC 1.5 V and comparing them to a fixed value

after A/D conversion. Set an arbitrary comparator level in CRAM 5FH.

DEFECT signal generationA DEFECT signal is generated by superimposing RF bottom detection

signals centered around DC 2.5 V and comparing them to a fixed value after A/D conversion. Set an arbitrary comparator level using the 18H

command.

AGC amplifier adjustmentAGC amplifier control can be adjusted using the MIRR signal generation

filter after A/D conversion. To monitor RF amplitude (G1O) stably, adjust

with the MIRR time constant (CRAM 5DH) in its the longest state.

The MIRR and DEFECT signals before A/D conversion can be monitored at the ATEST pin using the 37H command.



(6) 35H command (Setting of timing for 3T component extraction from RF signal)

	MSB			Com	mand			LSB					
	0	0	1	1	0	1	0	1					
	MSB				meter			LSB					
	0	3TS6	3TS5	3TS4	3TS3	3TS2	3TS1	3TS0					
									3TS2	3TS1	3TS0	3T E	_ E
									0	0	0	* 7.46 r	_
									0	0	1	14.9 n	_
									0	1	0	22.4 r	_
									0	1	1	29.8 r	_
									1	0	0	37.3 r	
									1	0	1	44.8 r	-
et4U.com									1	1	0	52.2 r	-
									1	1	1	59.7 r	r
													-
									3TS6	3TS5	3TS4	3TS3	
									0	0	0	0	-
									0	0	0	1	-
									0	0	1	0	
									0	0	1	1	
									0	1	0	0	
									0	1	0	1	_
									0	1	1	0	_
									0	1	1	1	_
									1	0	0	0	_
									1	0	0	1	_
									1	0	1	0	_
									1	0	1	1	_
									1	1	0	0	
									1	1	0	1	
									1	1	1	0	_
									1	1	1	1	

Remark The mark * indicates the contents set after a reset.

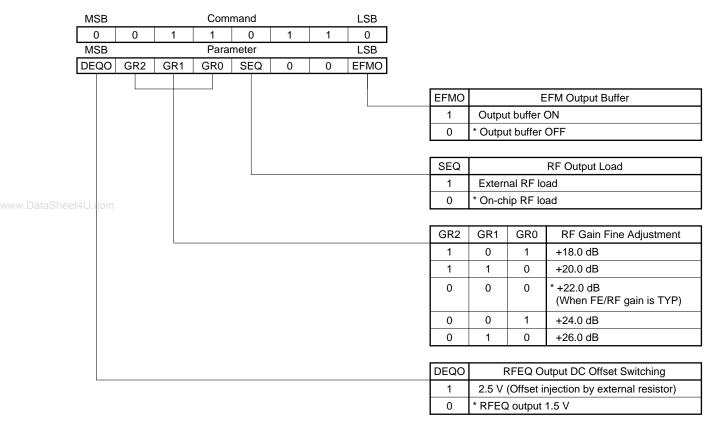
[Functional description]

3TS[6:0]: Sets the timing for extracting 3T components from RF signals.

Note that if this value is not set accurately, 11T and not 3T detection sensitivity will be high.



(7) 36H command (Settings of EFM output block buffer and RF amplifier external load resistor)



Remark The mark * indicates the contents set after a reset.

[Functional description]

EFMO: Sets EFM comparator output buffer ON or OFF.

Normally, chattering is avoided by using a 2-k Ω resistor on output.

SEQ: Used when there is an externally attached RF amplifier load.

GR[2:0]: Used in fine tuning of RF gain when an RF amplifier load is externally attached.

Performed by dividing the variation of ± 4 dB into five stages.

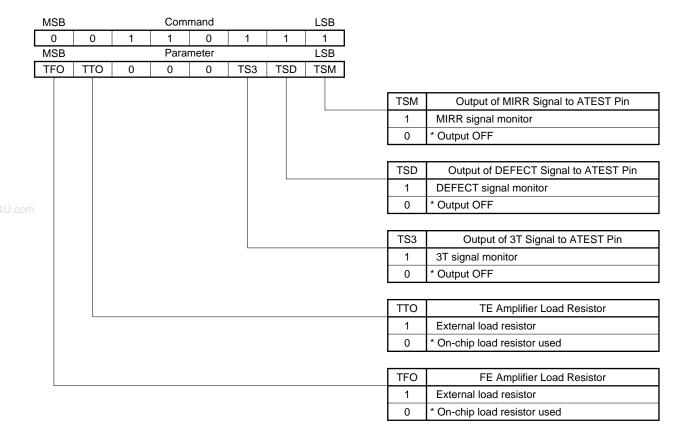
DEQO: Switches the RF amplifier output voltage.

When an RFEQ load resistor is externally attached, by setting this register to 2.5 V, the offset can be

adjusted using the external resistor.



(8) 37H command (Settings of output to ATEST pin and FE and TE amplifier load resistors)



Remark The mark * indicates the contents set after a reset.

[Functional description]

TSM: When TSM = 1, the MIRR signal is output from the ATEST pin.

TSD: When TSD = 1, the DEFECT signal is output from the ATEST pin.

TS3: When TS3 = 1, the 3T signal is output from the ATEST pin.

TTO: Selects whether the TE amplifier load resistor is on-chip or external.

The TE amplifier on-chip load resistor is 80 k Ω when a current input type is selected, and 160 k Ω when a

voltage input type is selected.

TFO: Selects whether the FE amplifier load resistor is on-chip or external.

The FE amplifier on-chip load resistor is 80 k Ω .

Cautions 1. The ATEST pin is for monitoring. Since its output drivability is not high, use it only for monitoring and normally leave it open. At the present stage, operation of the ATEST pin is not guaranteed.

> 2. Do not set two or more of the bits TSM, TSD, and TS3 to 1 at one time. Be sure to set only one of the bits to 1.



(9) 39H command (Settings of playback speed, EQ speed, APC amplifier polarity, and current input type)

MSB			Com	mand			LSB			
0	0	1	1	1	0	0	1			
MSB				meter		1	LSB	Ī		
LDS	0	IVS	SW2	APN	0	0	CV2			
								Г	CV2	Double-Speed Setting
									1	Set double-speed
									0	* Set single-speed
								_		
									APN	APC Circuit N-Sub or P-Sub Selection
									1	* APC circuit, N-Sub supported
4U.com									0	APC circuit, P-Sub supported
									SW2	RFEQ Single or Double SW Selection
									1	Use circuit on pin 79 EQ1 side
								L	0	* Use circuit on pin 78 EQ2 side
								_		
									IVS	Selection of Signal Input Method from Pickup
									1	Current input type
								L	0	* Voltage input type
								_		
									LDS	APC Circuit ON or OFF Selection
									1	APC circuit operation (LD control current output)
									0	* Stop APC circuit operation (LD control current output stopped)

Remark The mark * indicates the contents set after a reset.

[Functional description]

CV2: Selects the playback speed (double-speed).

APN: Selects whether the APC circuit supports N-Sub or P-Sub.

SW2: Selects the RFEQ circuit to use.

IVS: Set the appropriate value for the form of input from the pickup.

LDS: Selects whether the APC circuit (LD drive current controller) is ON or OFF.



3.3 Signal Processing System Commands

Table 3-5. Functions of Signal Processing System Commands

Command	Function	Reference
F0H	ON or OFF selection for muting and attenuation, ON or OFF selection for interpolate processing of uncorrectable data medium values, setting of number of interpolated frames for synchronization guard	p.43
F1H	CLV servo control	p.44
F2H	Readout-start Q code address specification, peak level data readout	p.45
F5H	Q code consecutive readout	p.47
F6H	LRCK pin polarity switching EMPH pin polarity switching	p.49
F7H	Attenuation ON or OFF	p.50
F8H	NOP (no target)	p.50
FAH	Attenuation amount setting (L-ch)	p.51
FBH	Attenuation amount setting (R-ch)	p.51
FCH	Error correcting capability selection, ON or OFF selection for subcode synchronization guard, forcible muting selection, bilingual mode selection, ON or OFF selection for digital out	p.52
FDH	C bit setting	p.53
FEH	Digital attenuation amount setting	p.53

ww.DataSheet4U.co



Table 3-6. List of Signal Processing System Commands

Coi	mmand				Paramet	er (Data)			
(Comm	nand Code)	MSB	6	5	4	3	2	1	LSB
	F0H	Н	L	Z	0	Т	М	А	0
	F1H	D	1	0	G	Т	D2	D1	D0
	F2H	PR	0	0	0	А3	A2	A1	A0
	F5H	None							
	F6H	0	0	0	0	PSEL	0	LP	EP
	F7H	PWM	0	0	0	WD2	WD1	MON	AT2
et4U.com	F8H	None							
1	FAH	L7	L6	L5	L4	L3	L2	L1	L0
1	FBH	R7	R6	R5	R4	R3	R2	R1	R0
1	FCH	TX	BR	BL	T1	T0	S	E1	E0
1	FDH	S3	S2	S1	S0	0	0	C1	C0
1	FEH	0	0	0	0	0	0	A1	A0

Caution Do not send an undefined command.



(1) F0H command (EFM signal input and audio/CD-ROM data output related parameter setting)

MSB			Com	mand			LSB					
1	1	1	1	0	0	0	0					
MSB			Parai	meter			LSB	-				
Н	L	Z	0	Т	М	Α	0					
									Z	М	Α	Sound Output
									0	0	0	Muting OFF
									0	0	1	Attenuation 1 ON
									0	1	0	* Muting ON
									0	1	1	Setting prohibited
									1	0	0	Zero-cross muting OFF
									1	0	1	Setting prohibited
									1	1	0	Zero-cross muting ON
									1	1	1	Setting prohibited
									Т	Interp	olate Pr	ocessing of Uncorrectable Data Medium Values
									0	* Yes (CD mod	e)
									1	No (C	D-ROM	mode)
									Н	L		Synchronization Guard
									0	0	2-fran	ne interpolation
									0	1	* 4-fran	ne interpolation
									1	0	8-fran	ne interpolation
									1	1	16-fra	me interpolation

Remark The mark * indicates the contents set after a reset.

[Functional description]

Z, M, A: Selects ON or OFF for muting and attenuation.

T: Selects CD mode or CD-ROM mode.

"0" CD mode

When an uncorrectable error is detected in the upper or lower 8 bits of audio data (16 bits), it is output after performing interpolation. High level is output from the FLAG pin at the same time.

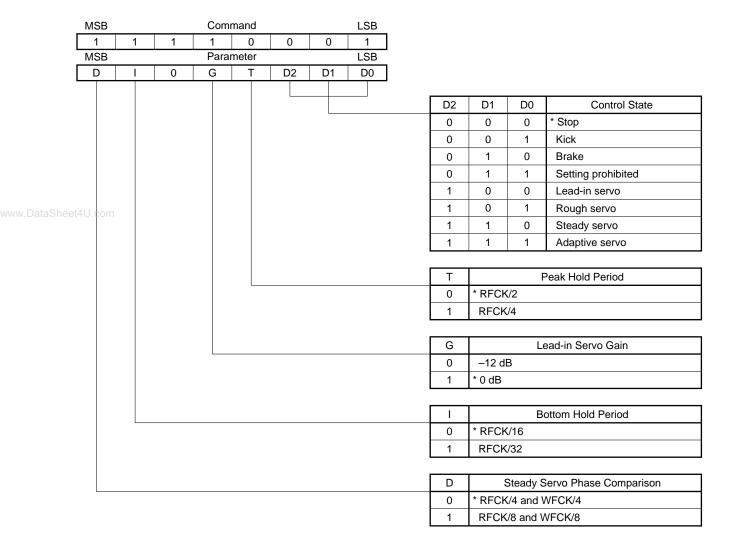
"1" CD-ROM mode

Even if an uncorrectable error is detected in the upper or lower 8 bits of CD-ROM data (16 bits), it is output without performing interpolation. However, the FLAG pin outputs whether an error was detected in either the upper or the lower 8 bits. This makes highly accurate erasure correction possible in a CD-ROM system connected to the μ PD63711.

H, L: Interpolates the signal based on 588 counter when the frame synchronization signal is not in the window. This specifies the number of frames.



(2) F1H command (CLV servo control)



Remark The mark * indicates the contents set after a reset.

[Functional description]

D[2:0]: Controls the CLV servo.

T: Selects whether to make the peak hold period of the lead-in servo RFCK/2 or RFCK/4.

G: Selects whether to make the gain of the lead-in servo –12 dB or 0 dB.

I: Selects whether to make the bottom hold period of the lead-in servo RFCK/16 or RFCK/32.

D: Selects whether to make the phase comparison signals of the steady servo RFCK/4 and WFCK/4 or RFCK/8 and WFCK/8.



(3) F2H command (Readout-start Q code address specification and peak level data readout)

MSB			Comr	mand			LSB						
1	1	1	1	0	0	1	0						
MSB			Parar	neter			LSB	_					
PR	0	0	0	А3	A2	A1	A0						
									A3	A2	A1	A0	Q Code Data
									0	0	0	0	CONTROL, ADR
									0	0	0	1	TNO
									0	0	1	0	POINT or X
									0	0	1	1	MIN
									0	1	0	0	SEC
n									0	1	0	1	FRAME
									0	1	1	0	ZERO
									0	1	1	1	PMIN or AMIN
									1	0	0	0	PSEC or ASEC
									1	0	0	1	PFRAME or AFRAME
									1	0	1	0	* ECT
									1	0	1	1	PKLU ^{Note}
									1	1	0	0	PKLD ^{Note}
									1	1	0	1	PKRU ^{Note}
									1	1	1	0	PKRD ^{Note}
								·	Note	The CC fl peak leve	ag must I data.	be chec	ked when reading
									PR		F	eak Reg	gister Clear
									0	0 *-			
									1	Peak register clear			

Remark The mark * indicates the contents set after a reset.

[Functional description]

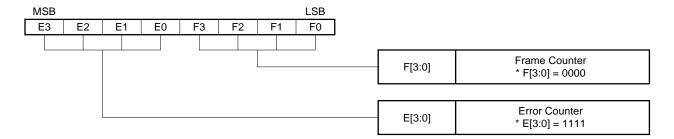
This command reads out the Q code data and peak level data indicated by parameters. Q code data consists of 8-bit units, and arbitrary data (80 bits excluding the CRC word) can be read by specifying a pointer address using parameters. The pointer addresses that can be specified using parameters are 00H through 0EH. Do not specify addresses other than these.

After data has been read out, the pointer address is incremented (\rightarrow 0 \rightarrow 1 \rightarrow 2 \rightarrow).

Q code data also can be read out using the F5H command. Refer to the F5H command for details of the reading method.

The Q code data that can be read out using this command and the F5H command is frame data for which CRC checking was OK. Therefore, CRC checking need not be performed on the microcontroller.

The contents of the internal register ECT of the LSI, which were read by AH parameter input following F2H command input, are described below. As shown below, the ECT register consists of an error counter in the upper 4 bits and a frame counter in the lower 4 bits.



Remark The mark * indicates the contents set after a reset.

[Functional description]

- F[3:0]: Whenever the Q code is updated, the value of this counter is incremented $(0 \to 1 \to ... \to F \to 0...)$. If a CRC error occurs, the Q code is not updated and the value of the counter does not change.
- E[3:0]: This counter indicates the CRC error state. If a CRC error occurs, the counter value is incremented (with a limit of FH). If an error does not occur, the value of the counter is reset (0H).

Peak level data is described below.

PKLU: L channel peak level data (upper 8 bits)
PKLD: L channel peak level data (lower 8 bits)
PKRU: R channel peak level data (upper 8 bits)
PKRD: R channel peak level data (lower 8 bits)

The maximum value of both the L channel and R channel in the a subcode 1 frame can be read.

Data is output as 16 bits divided into 8 upper bits and 8 lower bits.

The CC flag must be checked when reading peak level data.



(4) F5H command (Q code consecutive readout (excluding peak level data))

MSB		Command								
1	1	1	1	0	1	0	1			

[Functional description]

Use this command to read out consecutive Q code data starting from the address specified in the F2H command (incrementing the pointer). Refer to the F2H command for the relationship between the address pointer and Q code data

When a command other than the F2H, F5H, or F8H commands is input to the μ PD63711, the address pointer is initialized (put in the same state as after a reset) automatically to AH (refer to the F2H command).

After reading data, the pointer address is incremented (\rightarrow 9 \rightarrow A \rightarrow 0 \rightarrow 1 \rightarrow 2 \rightarrow ...).

The basic reading method is described first. This actually is used in combination with the method of reading n bytes of Q code data (described later).

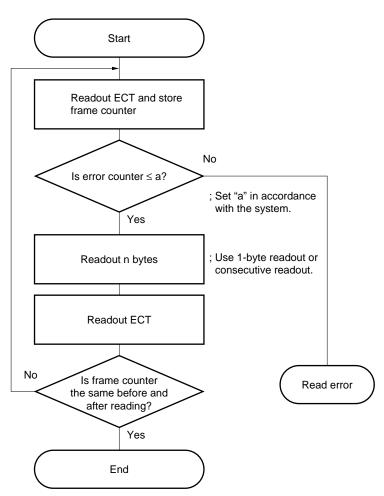
- To read out 1 byte of Q code data, use the F2H command.
- To read out multiple bytes of Q code data consecutively, read out according to the flowchart shown below.

Start Input readout command specifying Q code address (F2H) Input parameter (Q code address pointer) Readout Q code byte data indicated by pointer Increment Q code address pointer Q code Yes consecutive readout command (F5H) input? No End

Figure 3-2. Q Code Consecutive Readout Method

A flowchart for actually reading out n bytes of Q code data (read out n bytes starting from arbitrary position in a frame) is shown below.

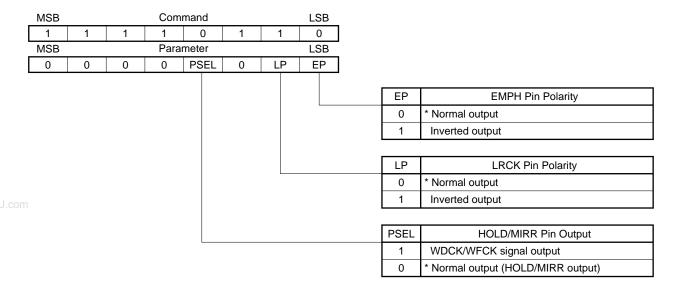
Figure 3-3. Readout Method of n Bytes of Q Code Data



ww.DataSheet4U.con



(5) F6H command (LRCK pin and EMPH pin polarity switching)



Remark The mark * indicates the contents set after a reset.

[Functional description]

EP: Selects whether EMPH pin output is normal or inverted.

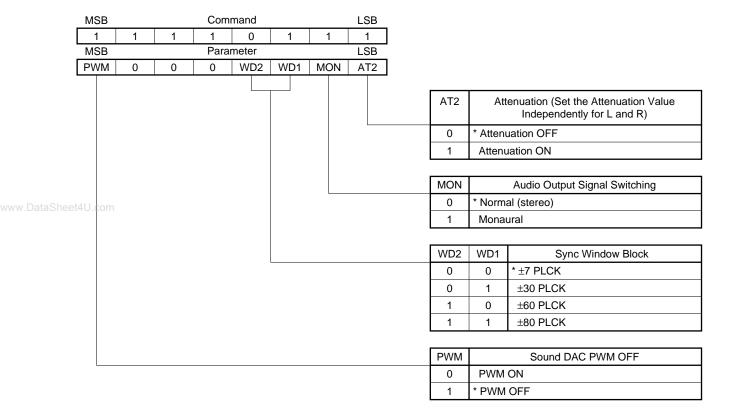
LP: Selects whether LRCK pin output is normal or inverted.

PSEL: Controls WDCK/WFCK signal output from HOLD/MIRR pin.

Caution When using the on-chip D/A converter, be sure to set LP = EP = 0.



(6) F7H command (Sound output mode and sync window width setting)



Remark The mark * indicates the contents set after a reset.

[Functional description]

AT2: Selects ON or OFF for attenuation. This is μ PD63703 equivalent attenuation. Set the amount of L-ch and

R-ch attenuation using the FAH and FBH commands, respectively.

MON: Selects stereo or monaural for the audio output signal.

WD[2:1]: Sets the width of the PLL synchronization detection window.

PWM: Selects ON or OFF for sound DAC PWM output.

In the default state (PWM OFF), PWM output (L+, L-, R+, R-) is fixed (+pin: H, -pin: L).

(7) F8H command (NOP command)

MSB		Command								
1	1	1	1	1	0	0	0			

[Functional description]

This command has no object.



(8) FAH and FBH commands (L-ch and R-ch attenuation amount setting)

MSB			Comi	mand			LSB				
1	1	1 1 1 1 0 1									
MSB		Parameter									
L7	L6	L5	L4	L3	L2	L1	L0				

L[7:0]	L-ch Attenuation Amount
00000000	-∞
00000001	-48 dB
00000010	-42.1 dB
	~
11111111	–0.03 dB

w Data Sheet 411 com

	MSE	3			Comi	mand			LSB		
	1		1 1 1 1 0 1								
	MSE	3			Parai	meter			LSB		
	R7		R6	R5	R4	R3	R2	R1	R0		
•											

R[7:0]	R-ch Attenuation Amount
00000000	-∞
00000001	–48 dB
00000010	-42.1 dB
	~
11111111	-0.03 dB

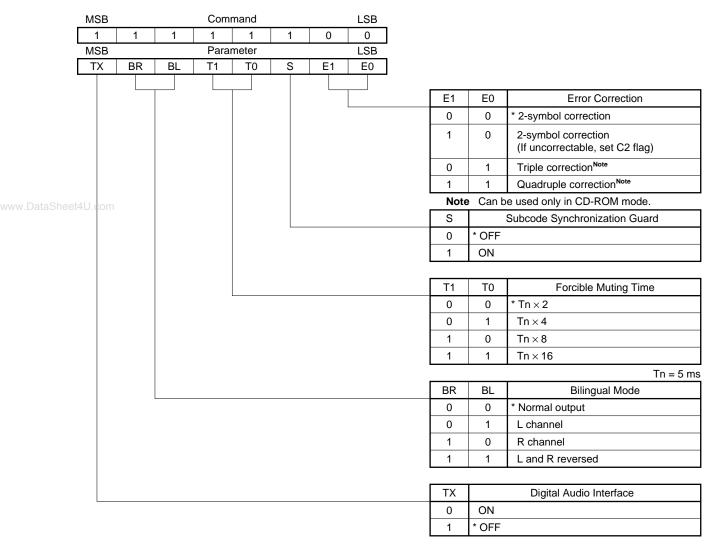
[Functional description]

L[7:0]: Sets the L-ch attenuation amount. R[7:0]: Sets the R-ch attenuation amount.

This is μ PD63703 equivalent attenuation. As in the case of the μ PD63703, this is undefined just after a reset. Therefore, after setting the attenuation amount using the FAH and FBH commands, execute attenuation with the F7H command.



(9) FCH command (Parameter setting)



Remark The mark * indicates the contents set after a reset.

[Functional description]

E[1:0]: Selects the error correcting capability.

S: Selects ON or OFF for subcode synchronization guard.

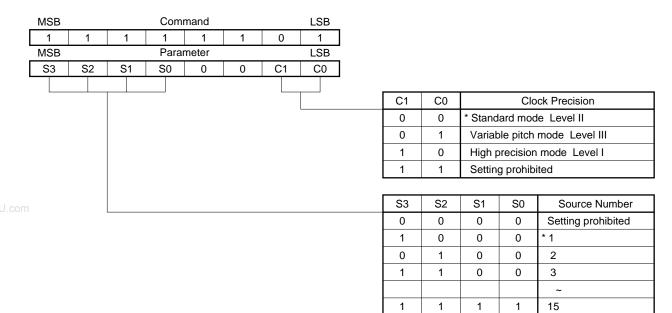
T[1:0]: Selects the forcible muting time.

BR, BL: Selects the bilingual mode.

TX: Selects ON or OFF for digital audio interface data output.



(10) FDH command (C bit setting)



Remark The mark * indicates the contents set after a reset.

[Functional description]

MCD

C[1:0]: Sets the clock precision of the C bit of the digital audio interface.

S[3:0]: Sets the source number of the C bit of the digital audio interface.

This command is only used to output values set for digital audio interface output and is unrelated to other operations of the LSI.

(11) FEH command (Digital attenuation amount setting)

Command

		Com	manu			LOD				
1	1	1	1	1	1	0				
		Para	meter			LSB	-			
0	0	0	0	0	A1	A0				
								A1	A0	Attenuation Amount
								0	0	−6 dB
								0	1	* –12 dB
								1	0	–18 dB
								1	1	–24 dB
	0	0 0	1 1 1 Para	1	1 1 1 1 1 Parameter	1 1 1 1 1 1 1 Parameter	1 1 1 1 1 0 Parameter LSB	1 1 1 1 1 0 Parameter LSB	1 1 1 1 1 0 0 0 0 0 0 0 A1 A0 A1 0	1

ICD

Remark The mark * indicates the contents set after a reset.

[Functional description]

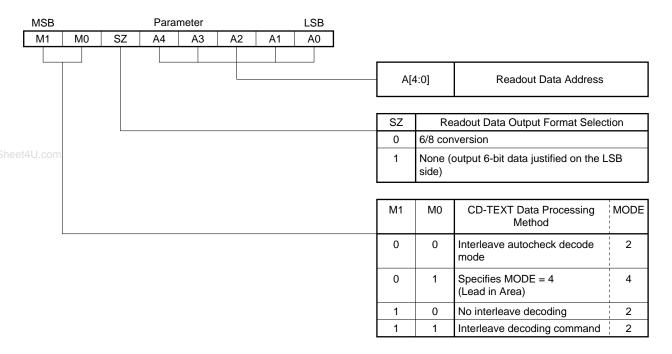
A[1:0]: Sets the digital attenuation amount.



3.4 CD-TEXT Function

(1) Parameter format

Inputs the parameters at the TSI pin in the format shown below. Command input is not necessary.



Remark The mark * indicates the contents set after a reset.

[Functional description]

A[4:0]: Specifies the readout data address within Pack.

If SZ = 0, specify an address from 0H to 11H.

If SZ = 1, specify an address from 0H to 17H.

If A[4:0] = 18H, output correction results information.

SZ: Selects 6/8 conversion of readout data.

"0" There is 6/8 conversion.

"1" There is no 6/8 conversion.

Use SZ = 0 as needed to read a MODE = 2 (program area) data area. In other cases, use SZ = 1.

M[1:0]: Sets the decoding mode.

If M1 = 1, specify the interleave mode in the M0 bit.

"00" Determines the presence of interleaving in a program area using Item of 3 bits and performs automatic de-interleaving.

"01" Specifies MODE = 4 (Lead in Area). Only CRC checking is performed and not correction.

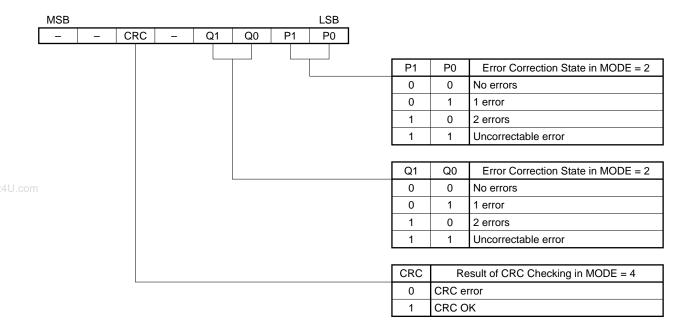
"10" No de-interleaving

"11" Has de-interleaving



(2) Correction result information

When A[4:0] = 18H, the following correction result information is output.



[Functional description]

P[1:0]: Shows the P series error correction state for MODE = 2.

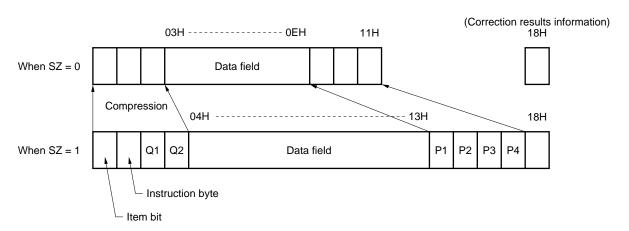
Q[1:0]: Shows the Q series error correction state for MODE = 2.

CRC: Shows the results of CRC checking for MODE = 4.

CRC = 1 means CRC checking was OK.

Refer to the CRC bit for MODE = 4 and the Q[1:0] and P[1:0] bits for MODE = 2 as needed.

Figure 3-4. Data Storage RAM Address Map Image (MODE = 2)

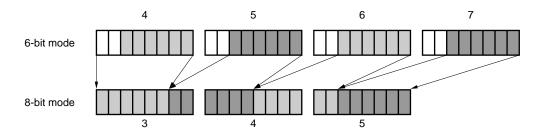


(3) 6/8 conversion

In MODE = 2 (Program Area), a constituent unit of data is 6 bits. If 8-bit mode is specified at this time, data output from the TSO pin is 6-bit data justified on the LSB side (the upper section of Figure 3-5).

If 6/8 conversion is specified, the 6-bit units of data are compressed and output (the lower section of Figure 3-5). Therefore, the time needed to read the data is shortened.

Figure 3-5. Data Compression in 6/8 Conversion



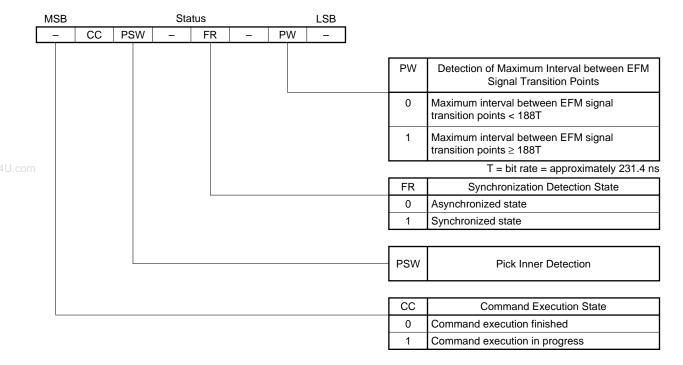
In 6/8 conversion based on SZ = 0, all data except 18H in the RAM is compressed. If you wish to read out the Item bit using a microcontroller and judge the possession of interleaving, specifying SZ = 1 is recommended.

www.DataSheet4U.com



3.5 Status

The status flags can be used to find out the internal state of the LSI.



[Functional description]

PW: This is the maximum value of the inversion interval of the EFM signal detected during the RFCK period (peak hold) compared to 188T (approximately 43.5 μ s). This flag is used to check whether or not rotation stopped when a brake was applied to the spindle for stopping the rotation of a disc. To avoid detection of errors due to defect (etc.), judge rotation to have stopped as long as PW = 1 multiple times in succession. Depending on the state of the EFM signal, PW may remain equal to 0 if the focus servo is out of position, so in addition to checking the PW flag, also check the focus servo state.

FR: In the EFM demodulation block, whether the output of the internal frame counter matches with the frame synchronization signal is sampled every WFCK/16 and a signal indicating a match or a non-match is output. If this signal indicates non-match 8 times in succession, this is regarded as an asynchronized state (FR = 0). At times other than this, it is regarded as a synchronized state (FR = 1).

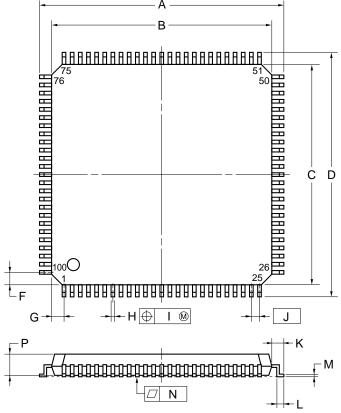
This flag is used to detect the mirror state of a disc and can be used in a sled servo or spindle servo guard. In addition, CLV adaptive servo mode switches the lead-in servo and normal servo according to this flag.

PSW: Outputs the state of the LIMIT pin (pin 39).

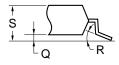
CC: When CC = 1, the processing of a command input from a microcontroller is being performed. The period in which CC = 1 is at most 12 μ s (peak level data readout time).

4. PACKAGE DRAWING

100 PIN PLASTIC LQFP (FINE PITCH) (14×14)



detail of lead end



NOTE

Each lead centerline is located within 0.08 mm (0.003 inch) of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS	INCHES
Α	16.00±0.20	0.630±0.008
В	14.00±0.20	0.551 ^{+0.009} -0.008
С	14.00±0.20	0.551 ^{+0.009} _{-0.008}
D	16.00±0.20	0.630±0.008
F	1.00	0.039
G	1.00	0.039
Н	$0.22^{+0.05}_{-0.04}$	0.009±0.002
I	0.08	0.003
J	0.50 (T.P.)	0.020 (T.P.)
K	1.00±0.20	$0.039^{+0.009}_{-0.008}$
L	0.50±0.20	0.020+0.008
М	0.17 ^{+0.03} -0.07	0.007+0.001
N	0.08	0.003
Р	1.40±0.05	0.055±0.002
Q	0.10±0.05	0.004±0.002
R	3°+7° -3°	3°+7° -3°
S	1.60 MAX.	0.063 MAX.

S100GC-50-8EU



5. RECOMMENDED SOLDERING CONDITIONS

The $\mu PD63711$ should be soldered and mounted under the following recommended conditions.

For the details of the recommended soldering conditions, refer to the document **Semiconductor Device Mounting Technology Manual (C10535E)**.

For soldering methods and conditions other than those recommended below, contact your NEC sales representative.

Table 5-1. Surface Mounting Type Soldering Conditions

 μ PD63711GC-8EU: 100-pin plastic LQFP (fine pitch) (14 × 14 mm)

/w.DataSheet4U.com

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Package peak temperature: 235°C, Time: 30 sec. Max. (at 210°C or higher), Count: two times or less, Exposure limit: 3 days ^{Note} (after that, prebake at 125°C for 10 hours)	IR35-103-2
VPS	Package peak temperature: 215°C, Time: 40 sec. Max. (at 200°C or higher), Count: two times or less	VP15-00-2
Wave soldering	Solder bath temperature: 260°C Max., Time: 10 sec. Max., Count: once, Preheating temperature: 120°C Max. (package surface temperature)	WS60-00-1
Partial heating	Pin temperature: 300°C Max., Time: 3 sec. Max. (per pin row)	-

Note After opening the dry pack, store it at 25°C or less and 65% RH or less for the allowable storage period.

Caution Do not use different soldering methods together (except for partial heating).

NEC μ PD63711

[MEMO]

/ww.DataSheet4U.com

[MEMO]

www.DataShoot4LL.com

NEC μ PD63711

[MEMO]

/ww.DataSheet4U.com

NOTES FOR CMOS DEVICES -

1 PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

ww.DataSheet4U.cor

(2) HANDLING OF UNUSED INPUT PINS FOR CMOS

Note:

No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

(3) STATUS BEFORE INITIALIZATION OF MOS DEVICES

Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

NEC μ PD63711

• The information contained in this document is being issued in advance of the production cycle for the device. The parameters for the device may change before final production or NEC Corporation, at its own discretion, may withdraw the device prior to its production.

- No part of this document may be copied or reproduced in any form or by any means without the prior written
 consent of NEC Corporation. NEC Corporation assumes no responsibility for any errors which may appear in
 this document.
- NEC Corporation does not assume any liability for infringement of patents, copyrights or other intellectual property
 rights of third parties by or arising from use of a device described herein or any other liability arising from use
 of such device. No license, either express, implied or otherwise, is granted under any patents, copyrights or other
 intellectual property rights of NEC Corporation or others.
- Descriptions of circuits, software, and other related information in this document are provided for illustrative
 purposes in semiconductor product operation and application examples. The incorporation of these circuits,
 software, and information in the design of the customer's equipment shall be done under the full responsibility
 of the customer. NEC Corporation assumes no responsibility for any losses incurred by the customer or third
 parties arising from the use of these circuits, software, and information.
- While NEC Corporation has been making continuous effort to enhance the reliability of its semiconductor devices, the possibility of defects cannot be eliminated entirely. To minimize risks of damage or injury to persons or property arising from a defect in an NEC semiconductor device, customers must incorporate sufficient safety measures in its design, such as redundancy, fire-containment, and anti-failure features.
- NEC devices are classified into the following three quality grades:
 - "Standard", "Special", and "Specific". The Specific quality grade applies only to devices developed based on a customer designated "quality assurance program" for a specific application. The recommended applications of a device depend on its quality grade, as indicated below. Customers must check the quality grade of each device before using it in a particular application.
 - Standard: Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots
 - Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)
 - Specific: Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

The quality grade of NEC devices is "Standard" unless otherwise specified in NEC's Data Sheets or Data Books. If customers intend to use NEC devices for applications other than those specified for Standard quality grade, they should contact an NEC sales representative in advance.

M5 98.8